

# **Specification Sheet**



## CIGW252010GL4R7MNE (2520 / EIA 1008)

Smart phones, Tablet, Wearable devices, Power converter modules, etc.

Small power inductor for mobile devices Low DCR structure and high efficiency inductor for power circuits. Monolithic structure for high reliability Free of all RoHS-regulated substances Halogen free



TYPE	Dimension [mm]						
TIPE	L	W	Т	D			
2520	2.5±0.2	2.0±0.2	1.0 max	0.55±0.25			

Part no. Size [inch/mm]	Size	Size Thickness Ir	Inductance	Inductance tolerance	DC Resistance [m 2] Rated DC C		Rated DC Cu	rrent (Isat) [A]	Rated DC Current (Irms) [A]	
	[mm] (max)	[uH]	(%)	Max.	Тур.	Max.	Тур.	Max.	Тур.	
CIGW252010GL4R7MNE	1008/2520	1.0	4.7	±20	216	180	1.4	1.7	1.4	1.6

\* Inductance : Measured with a LCR meter 4991A(Agilent) or equivalent (Test Freq. 1MHz, Level 0.1V)

\* DC Resistance : Measured with a Resistance HI-TESTER 3541(HIOKI) or equivalent

\* Maximum allowable DC current : Value defined when DC current flows and the initial value of inductance has decreased by 30% or when current flows and temperature has risen to 40 °C whichever is smaller. (Reference: ambient temperature is 25 °C±10)

(Isat) : Allowable current in DC saturation : The DC saturation allowable current value is specified when the decrease of the initial inductance value at 30% (Reference: ambient temperature is 25°C±10)

(Irms) : Allowable current of temperature rise : The temperature rise allowable current value is specified when temperature of

the inductor is raised 40 °C by DC current. (Reference: ambient temperature is 25 °C±10)

\* Absolute maximum voltage : Rated Voltage 20V.

\* Operating temperature range : -40 to +125°C (Including self-temperature rise)

<u>CIG</u>	w	<u>2520</u>	<u>10</u>	<u>GL</u>	<u>4R7</u>	M	<u>N</u>	<u>E</u>
		(3)						

(2) Type

(4) Thickness (10: 1.0mm)

(6) Inductance (4R7: 4.7 uH)

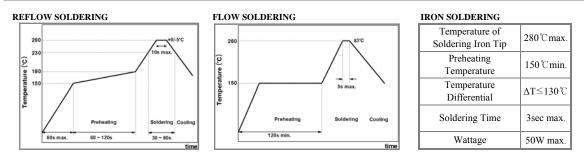
(1) Power Inductor

- (3) Dimensior (2520: 2.5mm × 2.0mm )
- (5) Remark (Characterization Code)

(7) Toleranc (M:±20%)

(8) Internal Code

(9) Packaging (C:paper tape, E:embossed tape)



Packaging Style	Quantity(pcs/reel)
Embossed Taping	3000 pcs

(W: Metal Composite Wire Wound Type)

		Unit : mm
	TYPE	2520
c	А	1.2
	В	0.8
B A B	С	2.0

TYPE	Dimension [mm]						
TIFE	L	W	Т	D			
2520	2.5±0.2	2.0±0.2	1.0 max	0.55±0.25			

Item	Specified Value		Test Condition		
Solderability	More than 90% of terminal electrode should be soldered newly.	After being dipped in flux for $4\pm1$ seconds, and preheated at $150 \sim 180^{\circ}$ C for $2 \sim 3$ min, the specimen shall be immersed in solder at $245\pm5^{\circ}$ C for $4\pm1$ seconds.			
Resistance to Soldering	No mechanical damage. Remaining terminal Electrode: 75% min. Inductance change to be within ±20% to the initial.	After being dipped in flux for $4\pm1$ seconds, and preheated at $150 \sim 180^{\circ}$ for $2 \sim 3$ min, the specimen shall be immersed in solder at $260\pm5^{\circ}$ for $10\pm0.5$ seconds.			
Thermal Shock (Temperature Cycle test)	No mechanical damage Inductance change to be within ±20% to the initial.	Repeat 100 cycles under -40 $\pm$ 3 °C for 30 min $\rightarrow$ 85	r the following conditions. ±3℃ for 30 min		
High Temp. Humidity Resistance Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2℃, 85%RH, for 500 Measure the test items a humidity for 24 hours.	±12 hours. fter leaving at normal temperature and		
Low Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PC at -55±2°C for 500±12 ho Measure the test items a humidity for 24hours.			
High Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	hours.	CB. Exposure at 125±2°C for 500±12		
High Temp. Humidity Resistance Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, Rated Current for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24 hours.			
High Temperature Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, Rated Current for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24 hours.			
Reflow Test	No mechanical damage Inductance change to be within ±20% to the initial	Peak 260±5°C, 3 times			
Vibration Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PCB. Vibrate as apply 10~55Hz, 1.5mm amplitude for 2 hours in each of three(X,Y,Z) axis (total 6 hours).			
	No mechanical damage	Bending Limit; 2mm Test Speed; 1.0mm/sec. Keep the test board at th PCB thickness : 1.6mm			
Bending Test		20 R340	Unit :mm 12		
		45	-		
	No indication of peeling shall occur on the terminal electrode.	W(kgf)	TIME(sec)		
Terminal Adhesion Test		0.5	10±1		
Drop Test	No mechanical damage Inductance change to be within ±20% to the initial.	Random Free Fall test or 1 meter, 10 drops	n concrete plate.		



**Data Sheet** 



### 1. Model : CIGW252010GL4R7MNE

### 2. Description

Part no. Size [inch/mm]	Size	Size Thickness	Inductance	Inductance tolerance	DC Resistance [m2] Rated DC Current (Isat) [A] Rated DC Current (Irms)				rrent (Irms) [A]	
	h/mm] [mm] (max)	[uH]	(%)	Max.	Тур.	Max.	Тур.	Max.	Тур.	
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when current flows and temperature has risen to 40°C whichever is smaller. (Reference: ambient temperature is 25°C±10)

(Isat) : Allowable current in DC saturation : The DC saturation allowable current value is specified when the decrease of the initial inductance value at 30% (Reference: ambient temperature is 25℃±10)

the initial inductance value at 30% (Reference: ambient temperature is  $25 \text{ C} \pm 10$ )

(Irms) : Allowable current of temperature rise : The temperature rise allowable current value is specified when temperature of the inductor is raised 40℃ by DC current. (Reference: ambient temperature is 25℃±10)

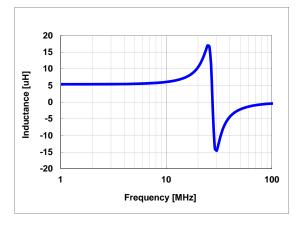
\* Absolute maximum voltage : Rated Voltage 20V.

\* Operating temperature range : -40 to +125°C (Including self-temperature rise)

#### 3. Characteristics data

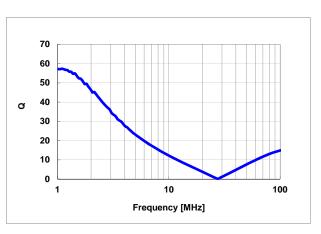
### 1) Frequency characteristics (Ls)

Agilent E4294A +E4991A , 1MHz to 1,000MHz



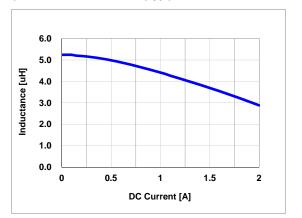
### 2) Frequency characteristics (Q)

Agilent E4294A +E4991A , 1MHz to 1,000MHz

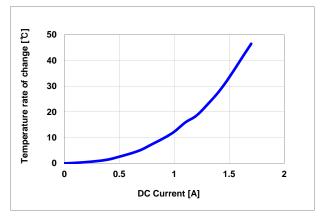


### 3) DC Bias characteristics (Typ.)

⚠



### 4)Temperature characteristics (Typ.)



Any data in this sheet are subject to change, modify or discontinue without notice The data sheets include the typical data for design reference only. If there is any question regarding the data sheets, please contact our sales personnel or application engineers

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